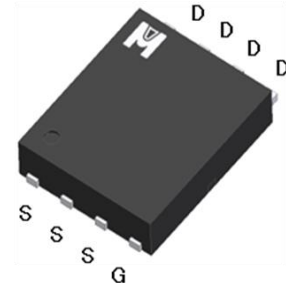
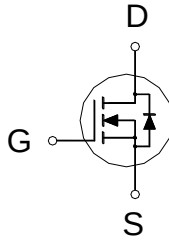




N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

|                     |               |
|---------------------|---------------|
| $BV_{DSS}$          | 30V           |
| $R_{DS(on)}$ (MAX.) | 5.0m $\Omega$ |
| $I_D$               | 75A           |



UIS, R<sub>g</sub> 100% Tested

RoHS & Halogen Free & TSCA Compliant



ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 °C Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS                     |                                                             | SYMBOL                            | LIMITS     | UNIT |
|------------------------------------------------|-------------------------------------------------------------|-----------------------------------|------------|------|
| Gate-Source Voltage                            |                                                             | $V_{GS}$                          | ±20        | V    |
| Continuous Drain Current                       | T <sub>C</sub> = 25 °C                                      | $I_D$                             | 75         | A    |
|                                                | T <sub>C</sub> = 100 °C                                     |                                   | 45         |      |
| Pulsed Drain Current <sup>1</sup>              |                                                             | $I_{DM}$                          | 160        |      |
| Avalanche Current                              |                                                             | $I_{AS}$                          | 53         |      |
| Avalanche Energy                               | L = 0.1mH, I <sub>D</sub> =53A, R <sub>G</sub> =25 $\Omega$ | $E_{AS}$                          | 140        | mJ   |
| Repetitive Avalanche Energy <sup>2</sup>       | L = 0.05mH                                                  | $E_{AR}$                          | 40         |      |
| Power Dissipation                              | T <sub>C</sub> = 25 °C                                      | $P_D$                             | 50         | W    |
|                                                | T <sub>C</sub> = 100 °C                                     |                                   | 26         |      |
| Operating Junction & Storage Temperature Range |                                                             | T <sub>J</sub> , T <sub>stg</sub> | -55 to 150 | °C   |

100% UIS testing in condition of V<sub>D</sub>=20V, L=0.1mH, V<sub>G</sub>=10V, I<sub>L</sub>=32A, Rated V<sub>DS</sub>=30V N-CH

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE  | SYMBOL           | TYPICAL | MAXIMUM | UNIT   |
|---------------------|------------------|---------|---------|--------|
| Junction-to-Case    | R <sub>θJC</sub> |         | 2.5     | °C / W |
| Junction-to-Ambient | R <sub>θJA</sub> |         | 50      |        |



<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle < 1%

<sup>3</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz.

Copper,

in a still air environment with  $T_A = 25^\circ\text{C}$ .

<sup>4</sup>Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS ( $T_J = 25\text{ }^{\circ}\text{C}$ , Unless Otherwise Noted)

| PARAMETER                                                               | SYMBOL             | TEST CONDITIONS                                            | LIMITS |      |           | UNIT       |
|-------------------------------------------------------------------------|--------------------|------------------------------------------------------------|--------|------|-----------|------------|
|                                                                         |                    |                                                            | MIN    | TYP  | MAX       |            |
| STATIC                                                                  |                    |                                                            |        |      |           |            |
| Drain-Source Breakdown Voltage                                          | $V_{(BR)DSS}$      | $V_{GS} = 0V, I_D = 250\mu A$                              | 30     |      |           | V          |
| Gate Threshold Voltage                                                  | $V_{GS(th)}$       | $V_{DS} = V_{GS}, I_D = 250\mu A$                          | 1      | 1.7  | 3         |            |
| Gate-Body Leakage                                                       | $I_{GSS}$          | $V_{DS} = 0V, V_{GS} = \pm 20V$                            |        |      | $\pm 100$ | nA         |
| Zero Gate Voltage Drain Current                                         | $I_{DSS}$          | $V_{DS} = 24V, V_{GS} = 0V$                                |        |      | 1         | $\mu A$    |
|                                                                         |                    | $V_{DS} = 20V, V_{GS} = 0V, T_J = 125\text{ }^{\circ}C$    |        |      | 25        |            |
| On-State Drain Current <sup>1</sup>                                     | $I_{D(ON)}$        | $V_{DS} = 10V, V_{GS} = 10V$                               | 75     |      |           | A          |
| Drain-Source On-State Resistance <sup>1</sup>                           | $R_{DS(ON)}$       | $V_{GS} = 10V, I_D = 30A$                                  |        | 4.4  | 5.0       | m $\Omega$ |
|                                                                         |                    | $V_{GS} = 4.5V, I_D = 24A$                                 |        | 5.1  | 6.5       |            |
| Forward Transconductance <sup>1</sup>                                   | $g_{fs}$           | $V_{DS} = 5V, I_D = 24A$                                   |        | 25   |           | S          |
| DYNAMIC                                                                 |                    |                                                            |        |      |           |            |
| Input Capacitance                                                       | $C_{iss}$          | $V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$                      |        | 1428 |           | pF         |
| Output Capacitance                                                      | $C_{oss}$          |                                                            |        | 234  |           |            |
| Reverse Transfer Capacitance                                            | $C_{rss}$          |                                                            |        | 122  |           |            |
| Gate Resistance                                                         | $R_g$              | $V_{GS} = 15mV, V_{DS} = 0V, f = 1MHz$                     |        | 2.3  |           | $\Omega$   |
| Total Gate Charge <sup>1,2</sup>                                        | $Q_g(V_{GS}=10V)$  | $V_{DS} = 15V, V_{GS} = 10V,$<br>$I_D = 30A$               |        | 26.9 |           | nC         |
|                                                                         | $Q_g(V_{GS}=4.5V)$ |                                                            |        | 12.8 |           |            |
| Gate-Source Charge <sup>1,2</sup>                                       | $Q_{gs}$           |                                                            |        | 3.6  |           |            |
| Gate-Drain Charge <sup>1,2</sup>                                        | $Q_{gd}$           |                                                            |        | 4.8  |           |            |
| Turn-On Delay Time <sup>1,2</sup>                                       | $t_{d(on)}$        | $V_{DS} = 15V,$<br>$I_D = 5A, V_{GS} = 10V, R_G = 3\Omega$ |        | 15   |           | nS         |
| Rise Time <sup>1,2</sup>                                                | $t_r$              |                                                            |        | 18   |           |            |
| Turn-Off Delay Time <sup>1,2</sup>                                      | $t_{d(off)}$       |                                                            |        | 45   |           |            |
| Fall Time <sup>1,2</sup>                                                | $t_f$              |                                                            |        | 20   |           |            |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T <sub>C</sub> = 25 °C) |                    |                                                            |        |      |           |            |
| Continuous Current                                                      | $I_S$              |                                                            |        |      | 75        | A          |
| Pulsed Current <sup>3</sup>                                             | $I_{SM}$           |                                                            |        |      | 150       |            |
| Forward Voltage <sup>1</sup>                                            | $V_{SD}$           | $I_F = I_S, V_{GS} = 0V$                                   |        |      | 1.3       | V          |
| Reverse Recovery Time                                                   | $t_{rr}$           | $I_F = I_S, dI_F/dt = 100A / \mu S$                        |        | 30   |           | nS         |
| Peak Reverse Recovery Current                                           | $I_{RM(REC)}$      |                                                            |        | 200  |           | A          |
| Reverse Recovery Charge                                                 | $Q_{rr}$           |                                                            |        | 12   |           | nC         |



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EMB05N03HR

<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .

<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.



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EMB05N03HR

Ordering & Marking Information:

Device Name: EMB05N03HR for EDFN 5 x 6



→ B05N03R: Device Name

→ ABCDEFG: Date Code

A: Assembly House

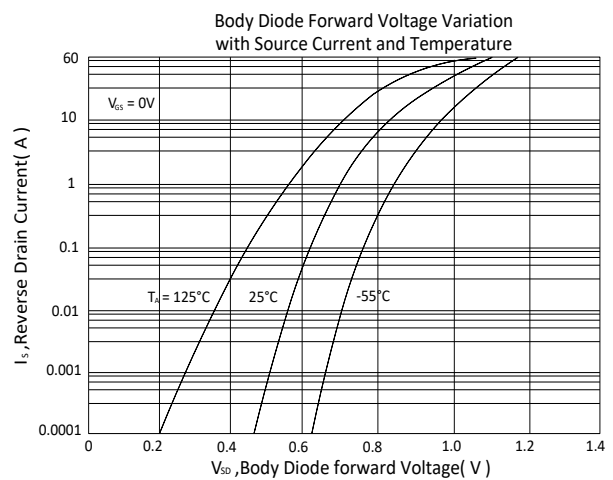
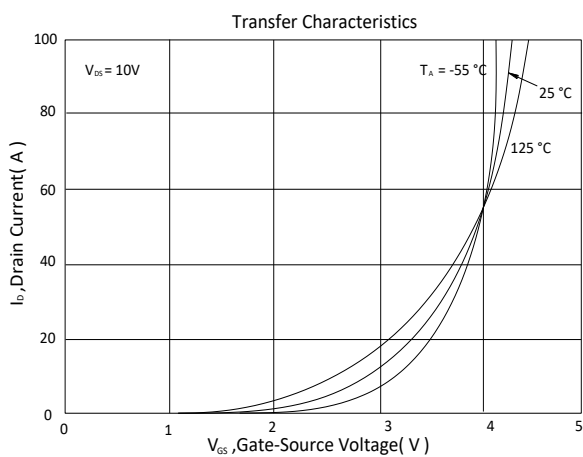
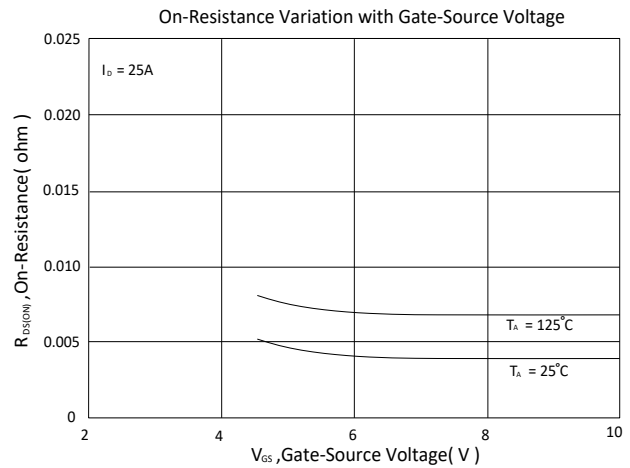
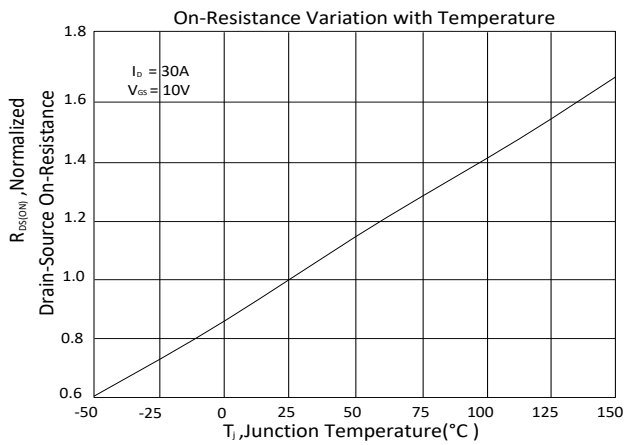
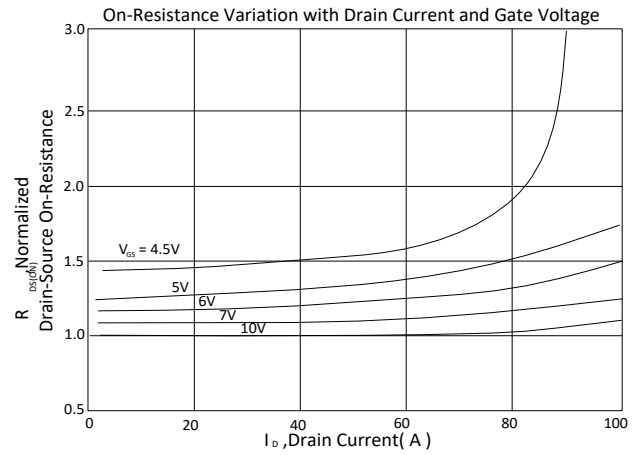
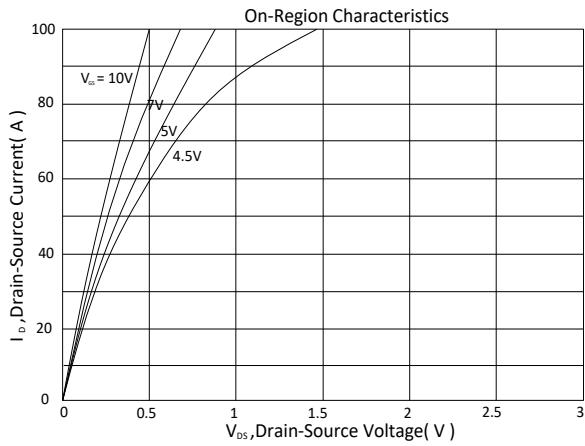
B: Year(A:2008 B:2009 C:2010....)

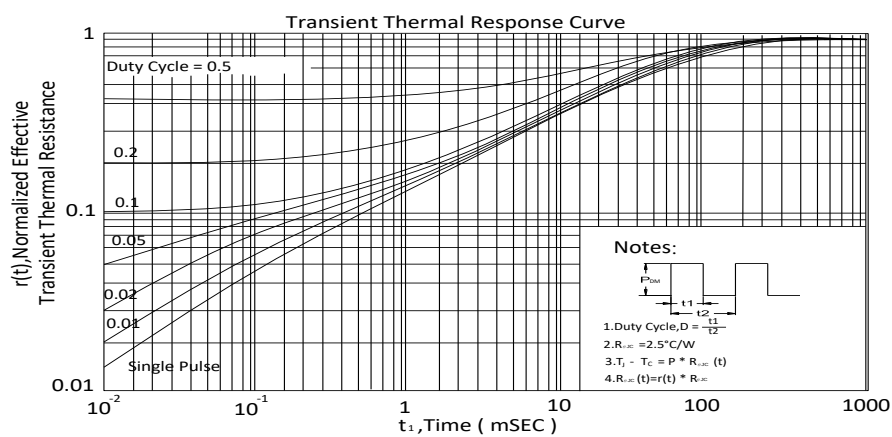
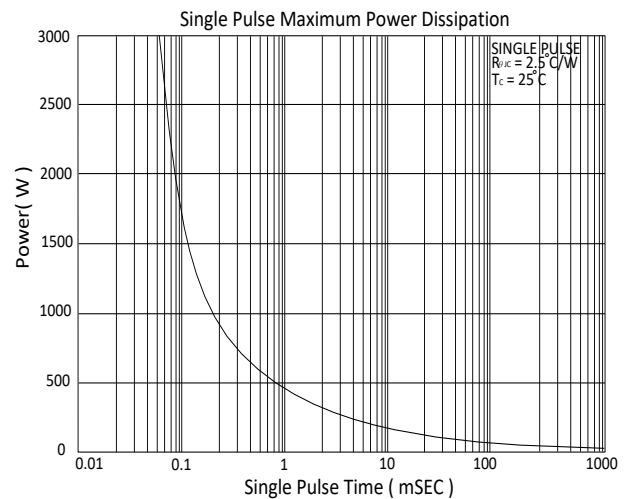
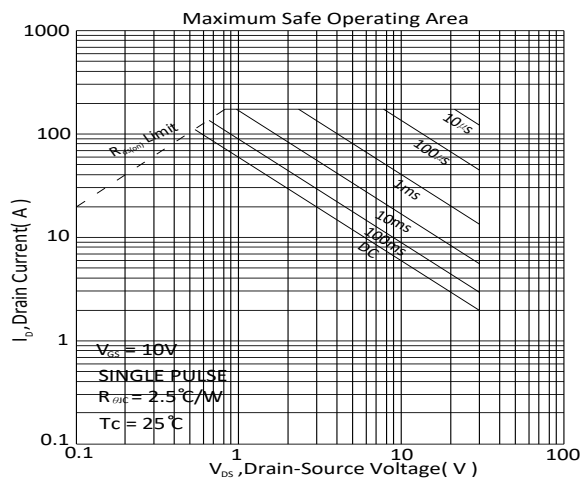
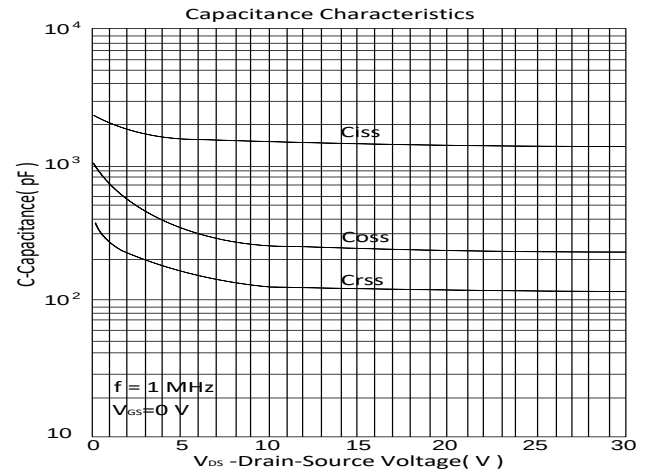
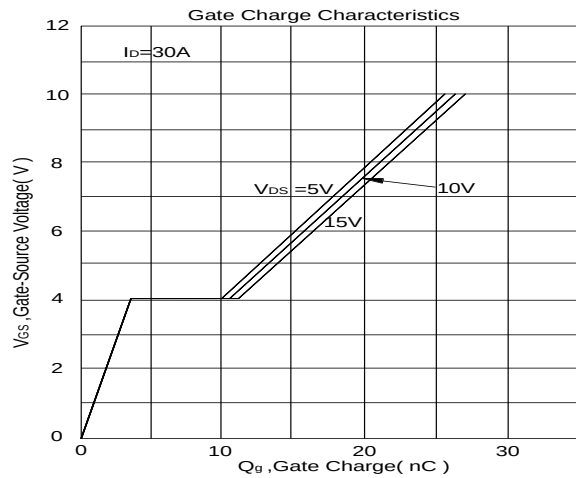
C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

DEFG: Serial No.



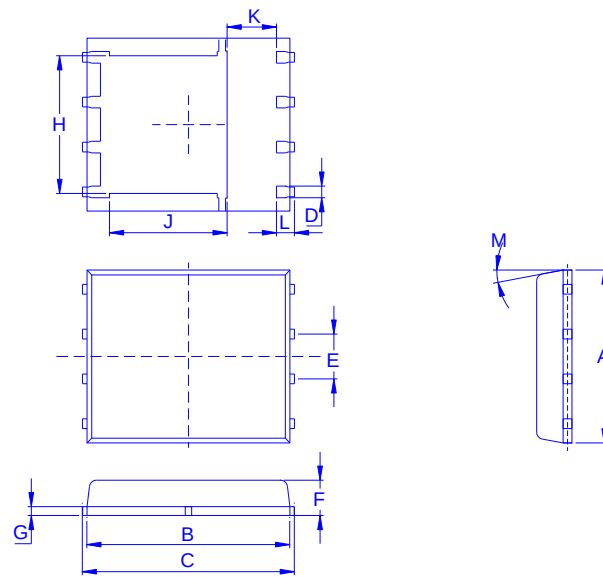
## TYPICAL CHARACTERISTICS







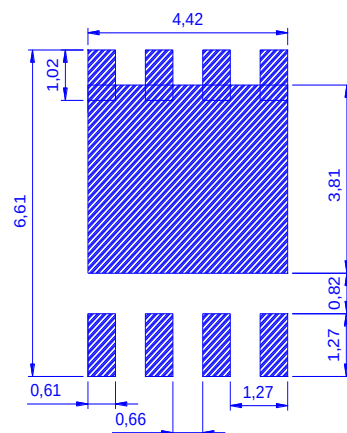
Outline Drawing



Dimension in mm

| Dimension | A   | B    | C    | D    | E    | F    | G    | H    | J    | K    | L    | M   |
|-----------|-----|------|------|------|------|------|------|------|------|------|------|-----|
| Min       | 4.8 | 5.55 | 5.9  | 0.3  | 1.17 | 0.85 | 0.15 | 3.61 | 3.18 | 1    | 0.38 | 0°  |
| Typ.      | 4.9 | 5.7  | 6    | 0.4  | 1.27 | 0.95 | 0.2  | 3.87 | 3.44 | 1.2  | 0.4  |     |
| Max       | 5.4 | 5.85 | 6.15 | 0.51 | 1.37 | 1.17 | 0.34 | 4.31 | 3.78 | 1.39 | 0.71 | 12° |

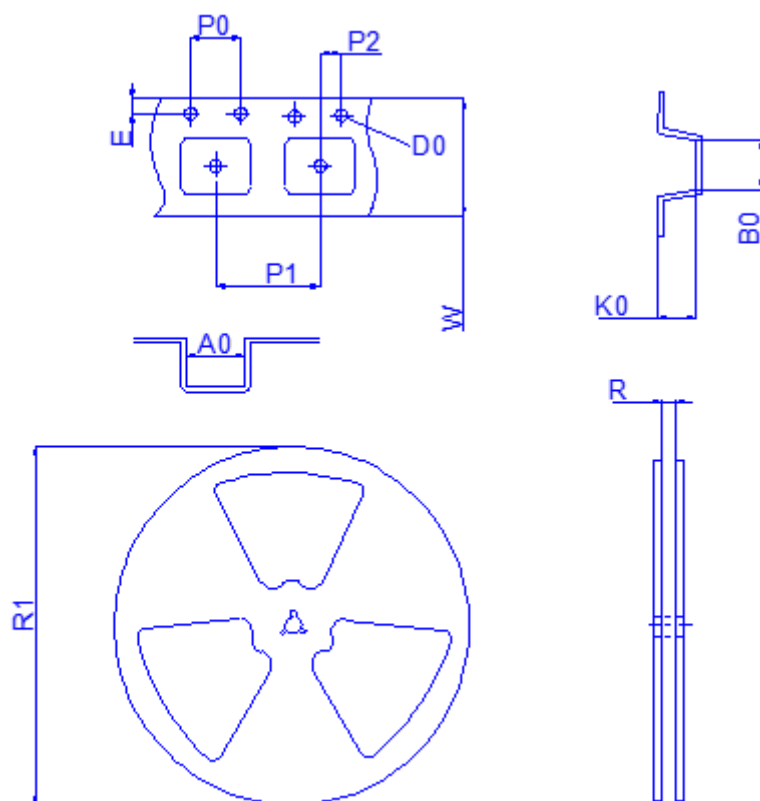
Recommended minimum pads







Tape&Reel Information:2500pcs/Reel



|                    |                                |
|--------------------|--------------------------------|
| Package            | EDFN5X6                        |
| Reel               | 13"                            |
| Device orientation | <p>FEED DIRECTION</p> <p>→</p> |

Dimension in mm

| Dimension | Carrier tape |     |     |     |     |     |     |     |     | Reel |     |
|-----------|--------------|-----|-----|-----|-----|-----|-----|-----|-----|------|-----|
|           | A0           | B0  | D0  | E   | K0  | P0  | P1  | P2  | W   | R    | R1  |
| Typ.      | 6.4          | 5.3 | 1.5 | 1.8 | 1.6 | 4   | 8   | 2   | 12  | 12.4 | 330 |
| ±         | 0.2          | 0.2 | 0.1 | 0.1 | 0.6 | 0.1 | 0.1 | 0.1 | 0.3 | 2    | 2   |